Type Hits Search Text DBs Time Stamp	DBS)Bs	Time Stam	a	Comments	Error Definition	Errors
USPAT; US-PGPUB; EPO; 2004/09/26 US-PGPUB; EPO; 2004/09/26 US-PGPUB; EPO; 2004/09/26 US-PGPUB; EPO; 14:52 IBM_TDB		USPAT; US-PGPUB; EPO; 2004/09/26 JPO; DERWENT; 14:52 IBM_TDB	2004/09/26 14:52	1			0
USPAT; 438/\$.ccls. and (conductive adj US-PGPUB; EPO; 2004/09/26 force adj microscope) IBM_TDB	uctive adj	USPAT; US-PGPUB; EPO; 2004/09/26 JPO; DERWENT; 15:24 IBM_TDB	2004/09/26 15:24	40			0
USPAT; BRS 0 438/17 and (conductive adj force US-PGPUB; EPO; 2004/09/26 JPO; DERWENT; 14:54 IBM_TDB	force	USPAT; US-PGPUB; EPO; 2004/09/26 JPO; DERWENT; 14:54 IBM_TDB	2004/09/26 14:54				0
USPAT; 438/\$.ccls. and (conductive adj US-PGPUB; EPO; 2004/09/26 force adj microscope) IBM_TDB	adj (USPAT; US-PGPUB; EPO; 2004/09/26 JPO; DERWENT; 14:55 IBM_TDB	2004/09/26 14:55				0
USPAT; 438/\$.ccls. and (conductive adj US-PGPUB; EPO; 2004/09/26 force adj microscope) IBM_TDB	USPAT; adj US-PGPUB; EPO; JPO; DERWENT; IBM_TDB		2004/09/26 15:01				0
USPAT; 324/\$.ccls. and (conductive adj US-PGPUB; EPO; 2004/09/26 JPO; DERWENT; 15:04 IBM_TDB	adj	USPAT; US-PGPUB; EPO; 2004/09/26 JPO; DERWENT; 15:04 IBM_TDB	2004/09/26 15:04				0
USPAT; 324/\$.ccls. and (conductive adj US-PGPUB; EPO; 2004/09/26 atomic adj force adj microscope) JPO; DERWENT; 16:13 IBM_TDB	<u> , -</u>	USPAT; US-PGPUB; EPO; 2004/09/26 JPO; DERWENT; 16:13 IBM_TDB	2004/09/26 16:13				,
USPAT; US-PGPUB; EPO; 2004/09/26 JPO; DERWENT; 15:12 IBM_TDB		USPAT; US-PGPUB; EPO; 2004/09/26 JPO; DERWENT; 15:12 IBM_TDB	2004/09/26 15:12				0

	Туре	Hits	Search Text	DBs	Time Stamp Comments	Comments	Error Definition	Errors
<u></u>	BRS	0	(("5585734").PN.) and (lekage adj current)	USPAT; US-PGPUB; EPO; 2004/09/26 JPO; DERWENT; 15:58 IBM_TDB	2004/09/26 15:58			0
10	BRS 1883	1883	324/\$.ccls. and (leakage adj current)	USPAT; US-PGPUB; EPO; 2004/09/26 JPO; DERWENT; 16:14 IBM_TDB	2004/09/26 16:14			0
7	BRS		((324/\$.ccls. and (leakage adj current)) and (measuring adj leakage adj current)) and (conductive adj atomic force adj microscope)	USPAT; US-PGPUB; EPO; 2004/09/26 JPO; DERWENT; 16:16 IBM_TDB	2004/09/26 16:16			0
12	BRS 120	120	(324/\$.ccls. and (leakage adj current)) and (measuring adj leakage adj current)	USPAT; US-PGPUB; EPO; 2004/09/26 JPO; DERWENT; 16:26 IBM_TDB	2004/09/26 16:26			0